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| QUALIFICATION PLAN #10524 |
| Test | Specification | Sample Size | Expected Completion Date |
| High Temperature Operating Life (HTOL)\* | JEDEC*JESD22-A108* | **1\*77** | **Nov 2013** |
| **1\*77** | **Nov 2013** |
| Early Life Failure (ELF) | MIL-STD-883, *Method 1015* | **3\*667** | **Nov 2013** |
| High Temperature Storage Life (HTSL) | JEDEC *JESD22-A103* | **1\*45** | **Oct 2013** |
| **1\*45** | **Oct 2013** |
| Latch-Up | JEDEC *JESD78* | **6** | **Oct 2013** |
| **6** | **Oct 2013** |
| Electrostatic Discharge*Human Body Model* | ESDA/JEDEC *JDS-001-2011* | **3/voltage** | **Oct 2013** |
| **3/voltage** | **Oct 2013** |
| Electrostatic Discharge*Field-Induced Charged Device Model* | JEDEC*JESD22-C101* | **3/voltage** | **Oct 2013** |
| **3/voltage** | **Oct 2013** |
| Electrostatic Discharge*Machine Model* | JEDEC*JESD22-A115* | **3/voltage** | **Oct 2013** |
| **3/voltage** | **Oct 2013** |
| Electrostatic Discharge *15kV IEC HBM* | IEC *6100-4-2* | **3/voltage** | **Nov 2013** |
| **3/voltage** |

\*Preconditioned per JEDEC/IPC J-STD-020